

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10779384	BOEKHORST, MARTIJN
	<b>Examiner</b> Chawan, Sheela C	<b>Art Unit</b> 2624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	154,278	6/22/07	SCC
345	419,443,441,611,418,589,424 , 421	"	"
708	831,821,422,290.102,103	"	"
381	573, 182, 300,386	"	"
382	154	12/3/07	SCC
345	419	12/3/07	SCC
708	102,103	12/3/07	SCC
ABOVE SEARCH UP- DATE.		12/3/07	SCC

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
SEARCH EAST AND OTHEWR DATA BASE, SEE THE SEARCH PRINT OUT.	6/22/07	SCC
INVENTOR NAME SEARCH	"	"
382/154,278,128.CCLS. ONLY US-PATENT	12/3/07	SCC
TEXT SEARCH		
345/419,441,611,418,589,424,421,443 .CCLS.	12/3/07	SCC
708/ 102,103,831,821,422,290.CCLS.	12/3/07	SCC
SEARCH EAST AND OTHER DATABASE SEE ATTACHED SEARCH HISTORY.	12/3/07	SCC
INTERFERENCE SEARCH , SEE SEARCH HISTORY PRINT OUT.	12/3/07	SCC
SEARCH IEEE OR INSPEC DATABASE.	12/3/07	SCC
381/573 ABOLISH.	12/3/07	SCC
UP-DATE THE SEARCH ABOVE.	12/3/07	SCC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	154	12/3/07	SCC
345	419	12/3/07	SCC
708	102,103	12/3/07	SCC